

Product Change Notification - JAON-16TUGT945

Date: 02 Oct 2016
Product Category: Memory
Notification subject: CCB 2652 Final Notice: Qualification of G600V molding compound for products available in 8L SOIC Chip On Lead (COL) package assembled at MTAI assembly site.
Notification text: **PCN Status:**
 Final notification

Microchip Parts Affected:

Please open the attachments found in the attachments field below labeled as PCN_#_Affected_CPN.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

Description of Change:

Qualification of G600V molding compound for products available in 8L SOIC Chip On Lead (COL) package assembled at MTAI assembly site.

Pre Change:

Using SG-8300GM molding compound

Post Change:

Using G600V molding compound

Pre and Post Change Summary:

	Pre Change	Post Change
Assembly Site	MTAI assembly site	MTAI assembly site
Wire material	Au wire	Au wire
Die attach material	8006NS	8006NS
Molding compound material	SG-8300GM	G600V
Lead frame material	CDA194	CDA194

Impacts to Data Sheet:

None

Change Impact:

None

Reason for Change:

To improve manufacturability by qualifying G600V molding compound.

Change Implementation Status:

In Progress

Estimated First Ship Date:

October 17, 2016 (date code: 1642)

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

Time Table Summary:

	June 2016					-->	September 2016					October 2016			
Workweek	22	23	24	25	26		35	36	37	38	39	40	41	42	43

Initial PCN Issue Date				X														
Qual Report Availability													X					
Final PCN Issue Date													X					
Estimated Implementation Date																		X

Method to Identify Change:

Traceability code

Qualification Report:

Please open the attachments included with this PCN labeled as PCN_#_Qual Report.

Revision History:

June 21, 2016: Issued initial notification.

October 2, 2016: Issued final notification. Attached the Qualification Report. Provided estimated first ship date on October 17, 2016.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachment(s):

[PCN_JAON-16TUGT945_Qual Report.pdf](#)

[PCN_JAON-16TUGT945_Affected CPN.pdf](#)

[PCN_JAON-16TUGT945_Affected CPN.xls](#)

Please contact your local [Microchip sales office](#) with questions or concerns regarding this notification.

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Affected Catalog Part Numbers (CPN)

PCN_JAON-16TUGT945
CATALOG_PART_NBR
23A1024-E/SN
23A1024-I/SN
23A1024T-E/SN
23A1024T-I/SN
23A512-E/SN
23A512-I/SN
23A512T-E/SN
23A512T-I/SN
23LC1024-E/SN
23LC1024-I/SN
23LC1024T-E/SN
23LC1024T-I/SN
23LC512-E/SN
23LC512-I/SN
23LC512T-E/SN
23LC512T-I/SN
23LCV1024-I/SN
23LCV1024T-I/SN
23LCV512-I/SN
23LCV512T-I/SN
24AA128-I/SN
24AA128T-I/SN
24AA512-I/SN
24AA512T-I/SN
24FC128-I/SN
24FC128T-I/SN
24FC512-I/SN
24FC512T-I/SN
24LC128-I/SN
24LC128T-I/SN
24LC256-I/SN
24LC256T-I/SN
24LC512-E/SN
24LC512-I/SN
24LC512T-E/SN
24LC512T-I/SN
25AA128-I/SN
25AA128T-I/SN
25AA256-I/SN
25AA256T-I/SN
25LC128-E/SN
25LC128-I/SN
25LC128T-E/SN

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Affected Catalog Part Numbers (CPN)

PCN_JAON-16TUGT945
CATALOG_PART_NBR
25LC128T-I/SN
25LC256-I/SN
25LC256T-I/SN



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**QUALIFICATION REPORT
RELIABILITY LABORATORY**

PCN #: JAON-16TUGT945

**Date
September 20, 2016**

**Qualification of G600V molding compound for products
available in 8L SOIC Chip On Lead (COL) package assembled
at MTAI assembly site.**

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PACKAGE QUALIFICATION REPORT

Purpose Qualification of G600V molding compound for products available in 8L SOIC
Chip On Lead (COL) package assembled at MTAI assembly site.

CN BC160944
QUAL ID Q16141
MP CODE TVAA14CYXD00
Part No. 23LC512-E/SN
Bonding No. BDM-001096 Rev. B
CCB No. 2652

Package

Type 8L SOIC
Package size 150 mils
Die thickness 8 mils
Die size 75.10 x 112.80 mils

Lead Frame

Paddle size 116 x 78 mils
Material CDA194
Surface Ag spot
Process Etch
Lead Lock No
Part Number 10100811
Treatment None

Die attach material

Epoxy 8006NS
Wire Au wire
Mold Compound G600V
Plating Composition Matte Tin



MICROCHIP PACKAGE QUALIFICATION REPORT

Manufacturing Information

Assembly Lot No.	Wafer No.	Date Code
MTAI171702428.000	U08F917122171.410	1629J7D
MTAI171802852.000	U08F917122171.410	1630PTY
MTAI171802853.000	U08F917122171.410	1630PU0

Result Pass Fail _____

8L SOIC (.150") assembled by MTAI pass reliability test per QCI-39000. This package was qualified the Moisture/Reflow Sensitivity Classification Level 1 at 260°C reflow temperature per IPC/JEDEC J-STD-020D standard.

Prepared By: Thinnapol Date: September 20, 2016 (Sr. Reliability Engineer)

(Mr. Thinnapol Nakkasun)

Approved By: Somnuek Date: September 20, 2016 (Reliability Manager)

(Mr. Somnuek Thongprasert)

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks
Moisture/Reflow Sensitivity Classification Test (At MSL Level 1)	85°C/ 85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH 3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243 (IPC/JEDEC J-STD-020D)	IPC/JEDEC C J-STD- 020D	135	0/135	Pass	

<u>Precondition Prior Perform Reliability Tests (At MSL Level 1)</u>	Electrical Test :+25°C,85°C and 125°C System: NEXTEST_PT	JESD22- A113	693(0)	693	Pass	Good Devices
	Bake 150°C, 24 hrs System: CHINEE			693		
	85°C/85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH			693		
	3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243			693		
	Electrical Test :+25°C and 85°C (With 1 lot 125°C on MTAI171702428.000) System: NEXTEST_PT			0/693		

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks	
Temp Cycle	Stress Condition: -65°C to +150°C, 500 Cycles System : TABAI ESPEC TSA-70H	JESD22- A104		231		Parts had been pre-conditioned at 260°C	
	Electrical Test: + 85°C (With 1 lot 125°C on MTAI171702428.000)		231(0)	0/231	Pass	77 units / lot	
	System: NEXTEST_PT						
	Bond Strength: Wire Pull (> 2.5 grams) Bond Shear (>15.00 grams)		15 (0)	0/15	Pass		
			15 (0)	0/15	Pass		
UNBIASED-HAST	Stress Condition: +130°C/85%RH, 96 hrs. System: HAST 6000X	JESD22- A118		231		Parts had been pre-conditioned at 260°C	
	Electrical Test: +25°C System: NEXTEST_PT		231(0)	0/231	Pass	77 units / lot	
HAST	Stress Condition: +130°C/85%RH, 96 hrs. Bias Volt: 2.2 Volts System: HAST 6000X	JESD22- A110		231		Parts had been pre-conditioned at 260°C	
	Electrical Test: +25°C and 85°C (With 1 lot 125°C on MTAI171702428.000)		231(0)	0/231	Pass	77 units / lot	
	System: NEXTEST_PT						
High Temperature Storage Life	Stress Condition: Bake 175°C, 504 hrs System: SHEL LAB	JESD22- A103		45		45 units	
	Electrical Test :+25°C,85°C and 125°C System: NEXTEST_PT		45(0)	0/45	Pass		

PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
Lead Integrity	45 Leads from a minimum of 5 units, 1 lot. System: Strain	JESD22- B105D	45(0) Leads	0/45	Pass	
Bond Strength	Wire Pull (> 2.5 grams)	M2011	30 (0) Wires	0/30	Pass	
Data Assembly	Bond Shear (>15.00 grams)	JESD22- B116	30 (0) bonds	0/30	Pass	